International IOR Rectifier

POWER MOSFET SURFACE MOUNT(SMD-1)

Product Summary

Part Number	RDS(on)	ΙD	
IRFN240	0.18 Ω	18A	

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

PD - 91548C

IRFN240 JANTX2N7219U JANTXV2N7219U REF:MIL-PRF-19500/596 200V, N-CHANNEL **HEXFET® MOSFETTECHNOLOGY**



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Surface Mount
- Dynamic dv/dt Rating
- Light-weight

Absolute Maximum Ratings

The Page 12 Co.	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	18	
ID @ VGS = 10V, TC = 100°C Continuous Drain Current		11	Α
I _{DM}	Pulsed Drain Current ①	72	-1.10
P _D @ T _C = 25°C	Max. Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS Single Pulse Avalanche Energy @		450	mJ
IAR Avalanche Current ①		18	А
EAR Repetitive Avalanche Energy ①		12.5	mJ
dv/dt Peak Diode Recovery dv/dt 3		5.0	V/ns
TJ	Operating Junction	-55 to 150	
TSTG	Storage Temperature Range		°C
7141-	Package Mounting Surface Temperature	300(for 5 seconds)	
, -1	Weight	2.6 (Typical)	g

For footnotes refer to the last page

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	200	_	_	V	VGS = 0V, ID = 1.0mA
ΔBVDSS/ΔTJ	Temperature Coefficient of Breakdown Voltage	_	0.29	_	V/°C	Reference to 25°C, I _D = 1.0mA
RDS(on)	Static Drain-to-Source On-State	_	_	0.18	Ω	VGS = 10V, ID = 11A (4)
, ,	Resistance	_	_	0.25	32	VGS = 10V, ID = 18A
VGS(th)	Gate Threshold Voltage	2.0	_	4.0	V	VDS = VGS, ID = 250μA
9fs	Forward Transconductance	6.1	_	_	S (7)	V _{DS} > 15V, I _{DS} = 11A ④
IDSS	Zero Gate Voltage Drain Current	_	_	25		VDS= 160V ,VGS=0V
			_	250	μΑ	VDS = 160V,
						VGS = 0V, TJ = 125°C
IGSS	Gate-to-Source Leakage Forward		_	100	^	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse	_	_	-100	nA	VGS = -20V
Qg	Total Gate Charge	_	_	60		VGS =10V, ID = 18A
Qgs	Gate-to-Source Charge	_	_	10.6	nC	VDS = 100V
Qgd	Gate-to-Drain ('Miller') Charge	_	_	37.6		
td(on)	Turn-On Delay Time	_	_	20		$V_{DD} = 100V, I_{D} = 18A,$
tr	Rise Time	_	_	105		VGS =10V, RG = 9.1Ω
td(off)	Turn-Off Delay Time	_	_	58	ns	
tf	Fall Time	_	_	67		
LS+LD	Total Inductance	_	4.0	_	nH	Measured from the center of drain
						pad to center of source pad.
C _{iss}	Input Capacitance	_	1300	_		VGS = 0V, VDS = 25V
Coss	Output Capacitance	_	400	_	pF	f = 1.0MHz
Crss	Reverse Transfer Capacitance	_	130	_	1	

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
Is	Continuous Source Current (Body Diode)		_		18	_	
ISM	Pulse Source Current (Body Diode) ①		_	_	72	Α	
VSD	Diode Forward Voltage		_		1.5	V	Tj = 25°C, IS = 18A, VGS = 0V ④
trr	Reverse Recovery Time		_	l	500	nS	Tj = 25°C, IF = 18A, di/dt ≤ 100A/μs
QRR	Reverse Recovery Charge		_		5.3	μC	V _{DD} ≤ 30V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by Lg + LD.					

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	_	_	1.0	°C/W	
RthJ-PCB	Junction-to-PC board	_	4.0	_	. C/vv	Soldered to a copper-clad PC board

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

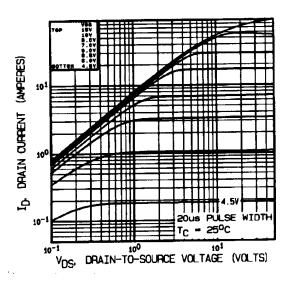


Fig 1. Typical Output Characteristics

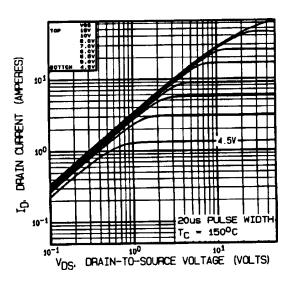


Fig 2. Typical Output Characteristics

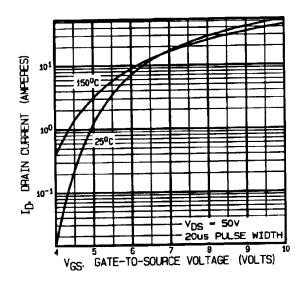


Fig 3. Typical Transfer Characteristics

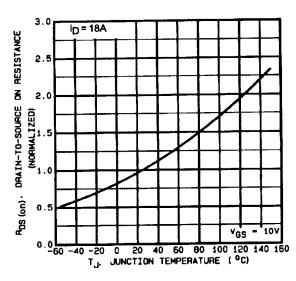


Fig 4. Normalized On-Resistance Vs. Temperature

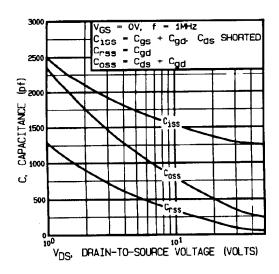
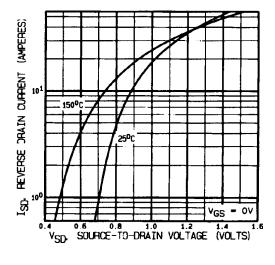


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage



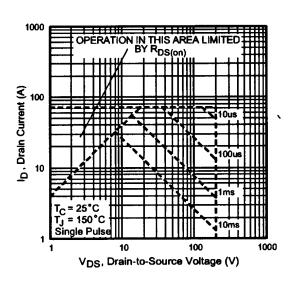


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

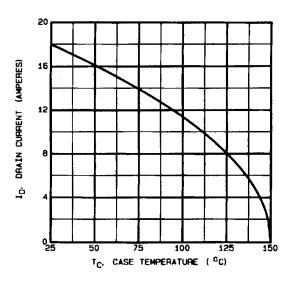


Fig 9. Maximum Drain Current Vs. Case Temperature

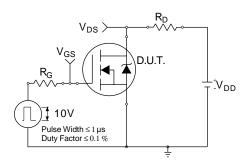


Fig 10a. Switching Time Test Circuit

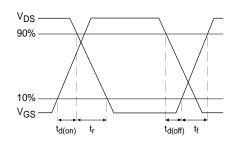


Fig 10b. Switching Time Waveforms

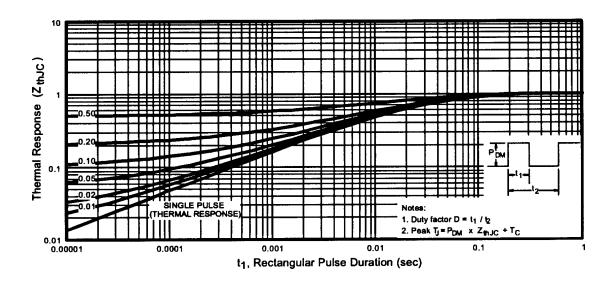


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

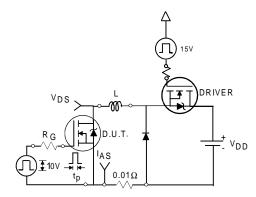


Fig 12a. Unclamped Inductive Test Circuit

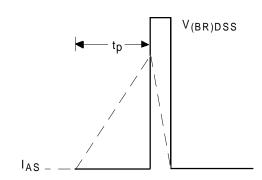


Fig 12b. Unclamped Inductive Waveforms

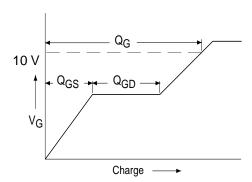


Fig 13a. Basic Gate Charge Waveform

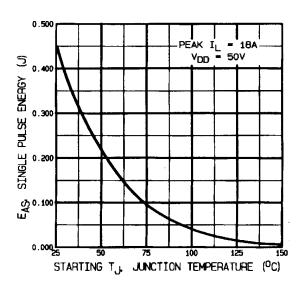


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

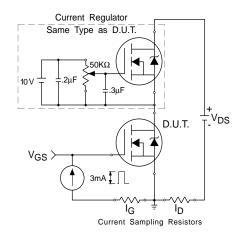


Fig 13b. Gate Charge Test Circuit

International

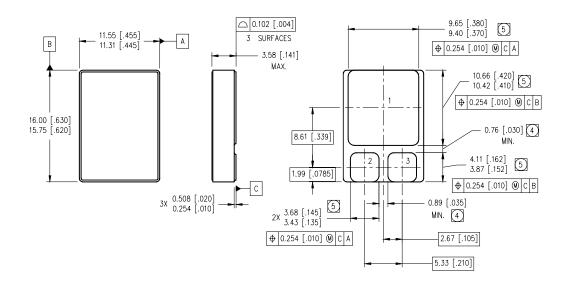
TOR Rectifier

IRFN240

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② $V_{DD} = 50V$, starting $T_J = 25$ °C, L = 1.3mH Peak $I_L = 18A$, $V_{GS} = 10V$
- $\label{eq:local_spin_spin} \begin{array}{l} \text{ (3)} \quad I_{SD} \leq 18\text{A, di/dt} \leq 150\text{A/}\mu\text{s,} \\ \text{V}_{DD} \leq 200\text{V, T}_{J} \leq 150^{\circ}\text{C} \\ \end{array}$
- ④ Pulse width \leq 300 µs; Duty Cycle \leq 2%

Case Outline and Dimensions — SMD-1



NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- (4) DIMENSION INCLUDES METALLIZATION FLASH.
 - DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

PAD ASSIGNMENTS

- 1- DRAIN
- 2- GATE
- 3- SOURCE



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.

Data and specifications subject to change without notice. 01/02